

<b>Notice of References Cited</b>	Application/Control No. 10/536,736	Applicant(s)/Patent Under Reexamination DUBERTRET ET AL.	
	Examiner Luke E. Karpinski	Art Unit 1609	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,417,961 A	05-1995	Nearn et al.	424/59
*	B	US-6,319,426 B1	11-2001	Bawendi et al.	252/301.4R
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	K	US-			
	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

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